

PC-3000 FLASH DATA RECOVERY ADVANCED TRAINING

seminar program

- 1. Opportunities and perspectives for using new version of the reader (version 4.0)
- 2. New structure of PC-3000 Flash
- 3. "Direct" TECH Mode reading of memory chip. Purpose
- 4. Modern types of memory chips
 - ▶ TLC memory chips. Features. Problems
 - ► Bad Column Managment
- 5. New algorithms of reading the memory
 - SDR and DDR memory chips
 - «Special reading rules» of memory chips
 - WL Algorithm of reading
- 6. Manual adding of flash memory chips into database
 - Methods of detecting memory chips parameters detection
- 7. Background analysis at memory chip reading
- 8. Different ways of improvement final quality of memory chips reading
- 9. Bitmap
 - Bitmap as a tool for detection page transformation
- 10. Manual and Automatical ways of inserts determination
 - ▶ Bitmap as a tool for verifying the correctness of removing
 - ► Another ways of removing "Bad" inserts

11. Map

- Creating map considering legend
- Map analysis
- Save and load with Map

12. Readout mode

- Creating sub map with ECC
- Analysis of mode parameters
- Log analysis



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13. ReadRetry command. Why it is necessary to use it

14. Special preparation modes

- Channel synchronization
- ▶ Block Rotation
- Joining by block for N sources
- Joining by Qword for N sources
- Joining by bytes for N sources
- Bank separation

15. Advanced input mode for "Block Number Type 1" algorithm

16. Compiler inside PC-3000 Flash

17. Features of some popular controllers

- Analysis of required data preparations and operations during data recovery
- Work features of some translators
- ► SM2236
- ► SM2234H
- ► SM3257EN
- ▶ PS2251-03
- Other

18. Analysis and improvement of final image

- Data quality Analysis
- Block version
- Shifts between banks
- Disk analysis
- Partition analysis
- Adding of virtual partition